

**Search Notes**

Application/Control No.

10/708,850

Examiner

Jean W. Désir

Applicant(s)/Patent under  
Reexamination

SHAN ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	663	9/7/06	
	665		
	667		
	669		
	670		
	666		
	699		
	700,701		
	908		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/7/06	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner